

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 17268-002001	Application No. 10/788,881
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Hitoshi Takeda et al.	
		Filing Date Herewith	Group Art Unit 2875

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>JS</i>	AA	2001/0019486	09/06/2001	Thominet			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Abstract	
							Yes	No
<i>JS</i>	AL	2002-231014	08/16/2002	Japan			X	
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
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(37 CFR §1.98(b))

Applicant  
Hitoshi Takeda et al.Filing Date  
February 27, 2004Group Art Unit  
2875**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>AK</i>	AA	20040179368	09/16/2004	Takeda et al.			
<i>AK</i>	AB	20040178737	09/16/2004	Takeda et al.			
<i>AK</i>	AC	20040179366	09/16/2004	Takeda et al.			
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